



**ALPHA & OMEGA**  
SEMICONDUCTOR

**AON6810**

**AlphaMOS 30V Common Drain N-Channel**

### General Description

- Latest Trench Power AlphaMOS ( $\alpha$ MOS LV) technology
- Very Low  $R_{DS(ON)}$  at 4.5V  $V_{GS}$
- Low Gate Charge
- ESD protection
- RoHS and Halogen-Free Compliant
- Common Drain
- Integrated Temp Sense Diode

### Application

- Battery Management

### Product Summary

$V_{DS}$	30V
$I_D$ (at $V_{GS}=10V$ )	20A
$R_{DS(ON)}$ (at $V_{GS}=10V$ )	< 4.4m $\Omega$
$R_{DS(ON)}$ (at $V_{GS}=4.5V$ )	< 6.5m $\Omega$

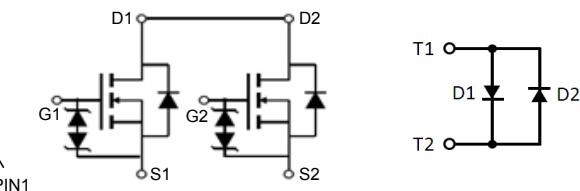
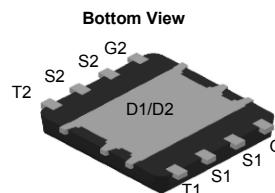
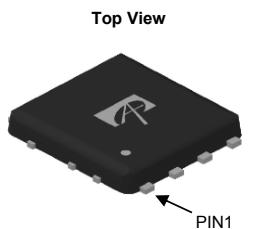
### Typical ESD protection

HBM Class 3A

100% UIS Tested  
100%  $R_g$  Tested



DFN5X6B



### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current <sup>G</sup>	$I_D$	20	A
$T_c=100^\circ C$		20	
Pulsed Drain Current <sup>C</sup>	$I_{DM}$	80	
Continuous Drain Current <sup>G</sup>	$I_{DSM}$	20	A
$T_A=70^\circ C$		20	
Avalanche Current <sup>C</sup>	$I_{AS}$	40	A
Avalanche energy $L=0.05mH$ <sup>C</sup>	$E_{AS}$	40	mJ
$V_{DS}$ Spike	100ns	$V_{SPIKE}$	V
Power Dissipation <sup>B</sup>	$P_D$	31	W
$T_c=100^\circ C$		12.5	
Power Dissipation <sup>A</sup>	$P_{DSM}$	4.1	W
$T_A=70^\circ C$		2.6	
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150	°C

### Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient <sup>A</sup>	$R_{\theta JA}$	24	30	°C/W
Maximum Junction-to-Ambient <sup>D</sup>		53	64	°C/W
Maximum Junction-to-Case	$R_{\theta JC}$	3	4	°C/W

**Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$\text{ID}=250\mu\text{A}, \text{V}_{\text{GS}}=0\text{V}$	30			V
$\text{I}_{\text{DSS}}$	Zero Gate Voltage Drain Current	$\text{V}_{\text{DS}}=30\text{V}, \text{V}_{\text{GS}}=0\text{V}$ $T_J=125^\circ\text{C}$			1 5	$\mu\text{A}$
$\text{I}_{\text{GSS}}$	Gate-Body leakage current	$\text{V}_{\text{DS}}=0\text{V}, \text{V}_{\text{GS}}=\pm16\text{V}$			$\pm10$	$\mu\text{A}$
$\text{V}_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_{\text{D}}=250\mu\text{A}$	1.4	1.8	2.2	V
$\text{R}_{\text{DS}(\text{ON})}$	Static Drain-Source On-Resistance	$\text{V}_{\text{GS}}=10\text{V}, \text{I}_{\text{D}}=20\text{A}$ $T_J=125^\circ\text{C}$	3.6	4.4		$\text{m}\Omega$
		$\text{V}_{\text{GS}}=4.5\text{V}, \text{I}_{\text{D}}=20\text{A}$	4.8	5.8		$\text{m}\Omega$
$\text{g}_{\text{FS}}$	Forward Transconductance	$\text{V}_{\text{DS}}=5\text{V}, \text{I}_{\text{D}}=20\text{A}$	5.2	6.5		$\text{S}$
$\text{V}_{\text{SD}}$	Diode Forward Voltage	$\text{I}_{\text{S}}=1\text{A}, \text{V}_{\text{GS}}=0\text{V}$	0.68	1		V
$\text{V}_{\text{FD}1}$	Sense Diode Forward Voltage	$\text{I}_{\text{F}}=50\mu\text{A}$	0.72	0.78		V
$\text{V}_{\text{FD}2}$		$\text{I}_{\text{F}}=50\mu\text{A}$	0.72	0.78		
$\text{I}_{\text{S}}$	Maximum Body-Diode Continuous Current <sup>G</sup>				20	A
<b>DYNAMIC PARAMETERS</b>						
$\text{C}_{\text{iss}}$	Input Capacitance	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=15\text{V}, \text{f}=1\text{MHz}$	1720			$\text{pF}$
$\text{C}_{\text{oss}}$	Output Capacitance		746			$\text{pF}$
$\text{C}_{\text{rss}}$	Reverse Transfer Capacitance		61			$\text{pF}$
$\text{R}_g$	Gate resistance	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=0\text{V}, \text{f}=1\text{MHz}$	2.6	5.2	7.8	$\Omega$
<b>SWITCHING PARAMETERS</b>						
$\text{Q}_{\text{g}}(10\text{V})$	Total Gate Charge	$\text{V}_{\text{GS}}=10\text{V}, \text{V}_{\text{DS}}=15\text{V}, \text{I}_{\text{D}}=20\text{A}$	24	34		$\text{nC}$
$\text{Q}_{\text{g}}(4.5\text{V})$	Total Gate Charge		11	20		$\text{nC}$
$\text{Q}_{\text{gs}}$	Gate Source Charge		5.9			$\text{nC}$
$\text{Q}_{\text{gd}}$	Gate Drain Charge		3.2			$\text{nC}$
$t_{\text{D}(\text{on})}$	Turn-On Delay Time	$\text{V}_{\text{GS}}=10\text{V}, \text{V}_{\text{DS}}=15\text{V}, \text{R}_{\text{L}}=0.75\Omega, \text{R}_{\text{GEN}}=3\Omega$	5.8			ns
$t_r$	Turn-On Rise Time		3.5			ns
$t_{\text{D}(\text{off})}$	Turn-Off Delay Time		57.5			ns
$t_f$	Turn-Off Fall Time		70			ns
$t_{\text{rr}}$	Body Diode Reverse Recovery Time	$\text{I}_{\text{F}}=20\text{A}, \text{dI}/\text{dt}=500\text{A}/\mu\text{s}$	20			ns
$Q_{\text{rr}}$	Body Diode Reverse Recovery Charge	$\text{I}_{\text{F}}=20\text{A}, \text{dI}/\text{dt}=500\text{A}/\mu\text{s}$	30			$\text{nC}$

A. The value of  $R_{\text{DSM}}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{\text{DSM}}$  is based on  $R_{\text{DSM}} \leq 10\text{s}$  and the maximum allowed junction temperature of  $150^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(\text{MAX})}=150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature  $T_{J(\text{MAX})}=150^\circ\text{C}$ .

D. The  $R_{\text{WA}}$  is the sum of the thermal impedance from junction to case  $R_{\text{JWC}}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(\text{MAX})}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ .

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**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

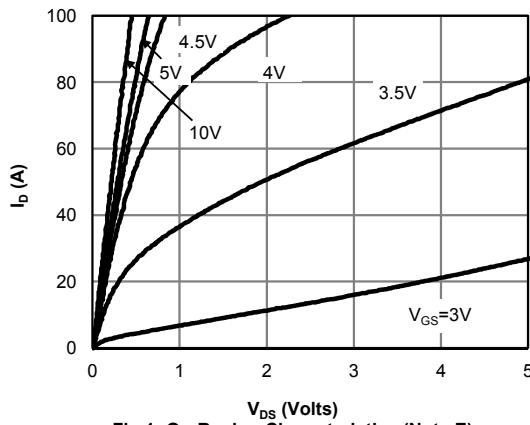


Fig 1: On-Region Characteristics (Note E)

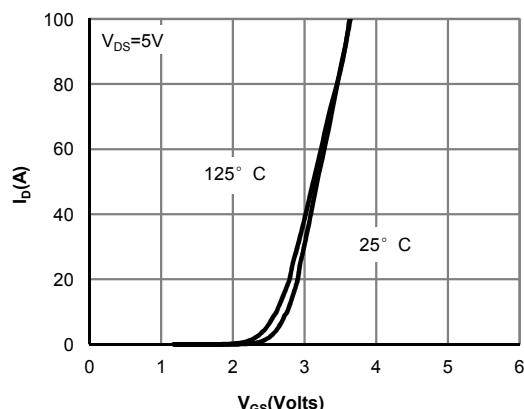


Figure 2: Transfer Characteristics (Note E)

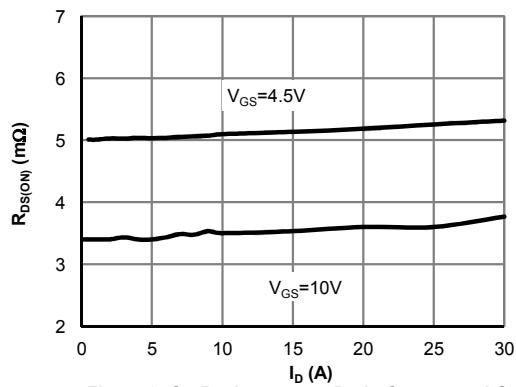


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

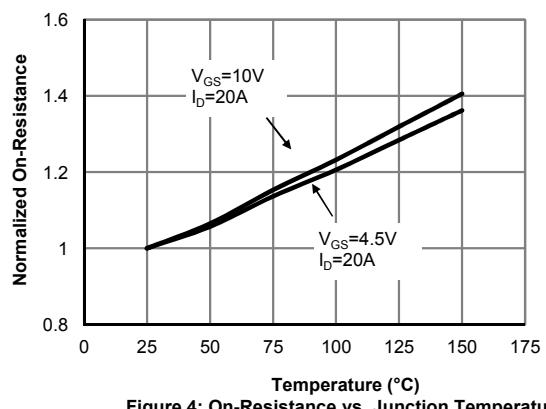


Figure 4: On-Resistance vs. Junction Temperature (Note E)

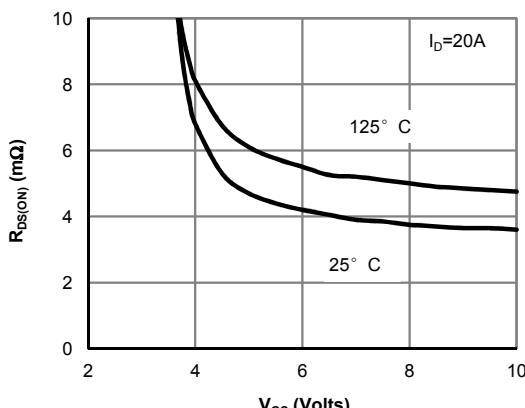


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

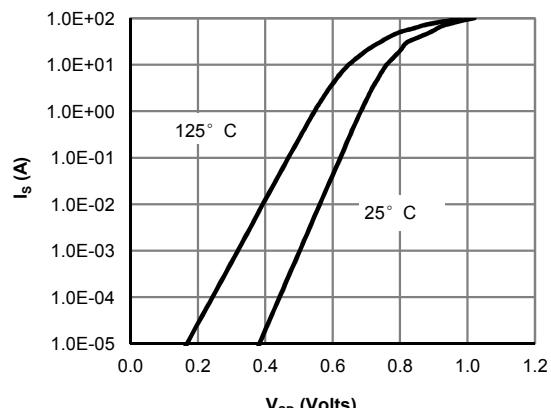


Figure 6: Body-Diode Characteristics (Note E)



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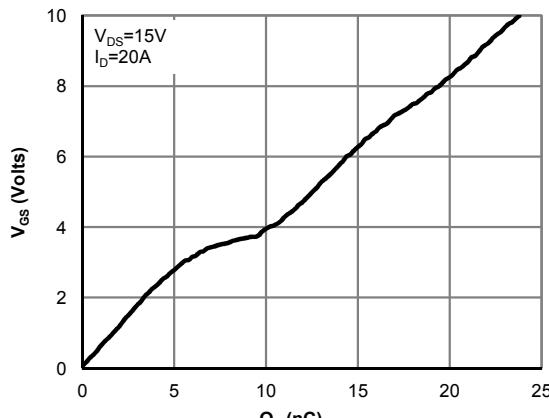


Figure 7: Gate-Charge Characteristics

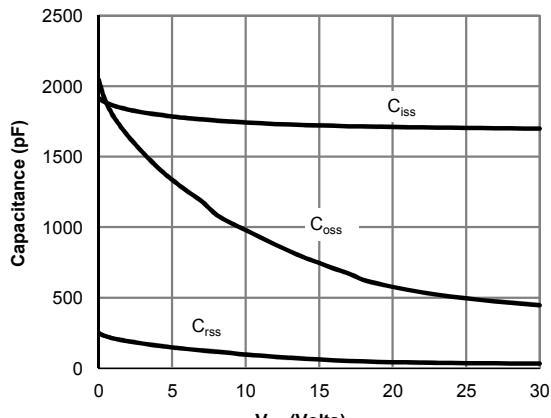
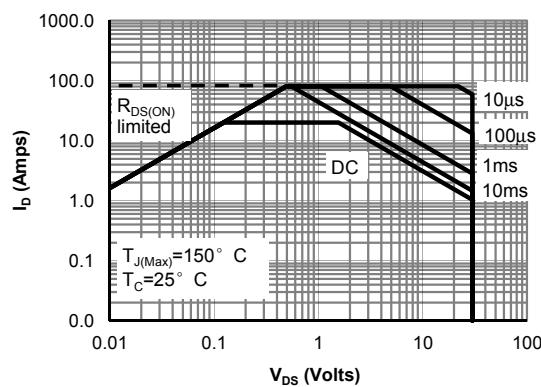


Figure 8: Capacitance Characteristics



VGS> or equal to 4.5V  
Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

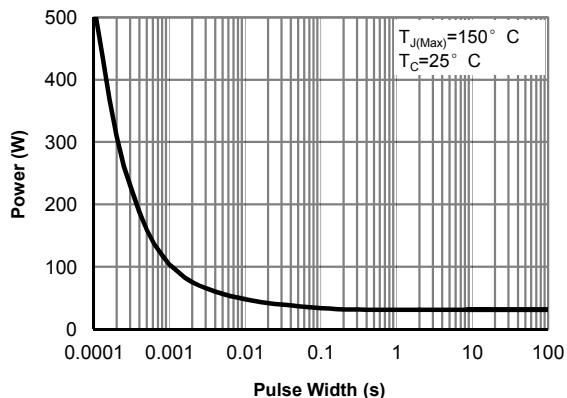


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

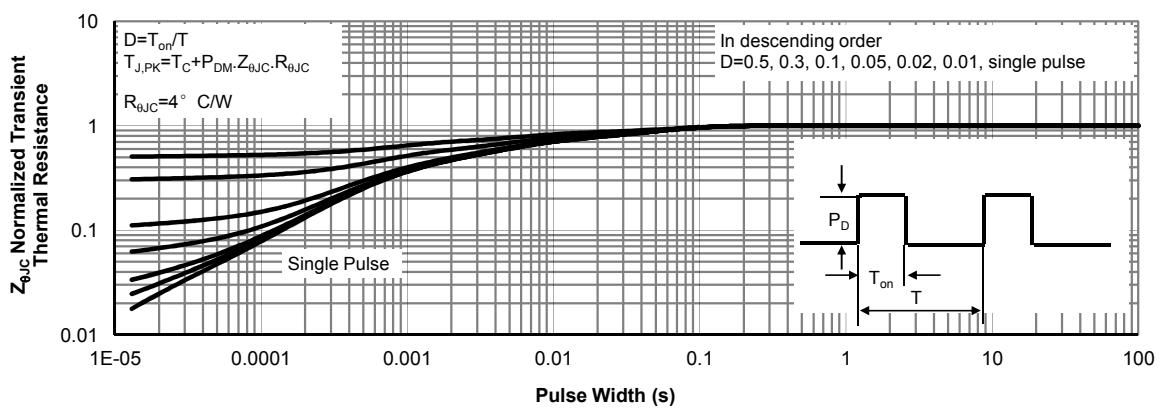


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



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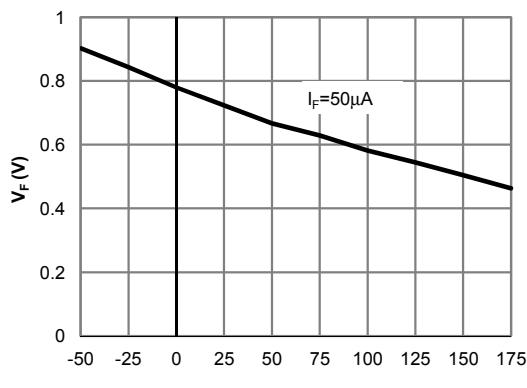


Figure 12: Sense Diode Forward Voltage vs.  
Temperature

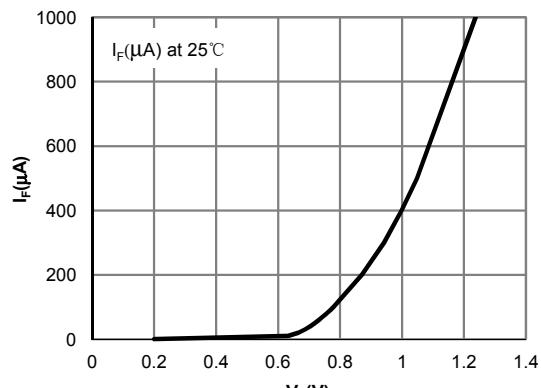


Figure 13: Sense Diode Forward Voltage

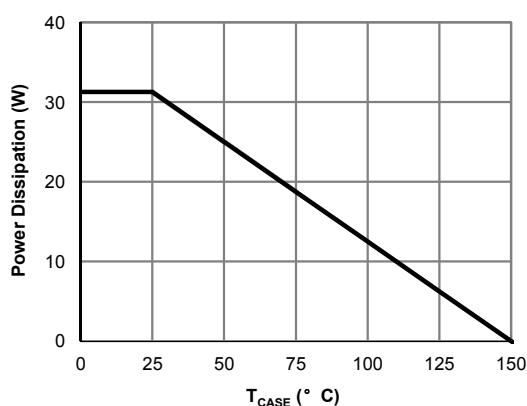


Figure 14: Power De-rating (Note F)

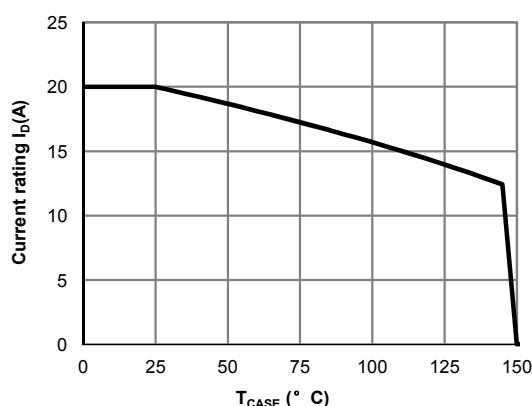


Figure 15: Current De-rating (Note F)

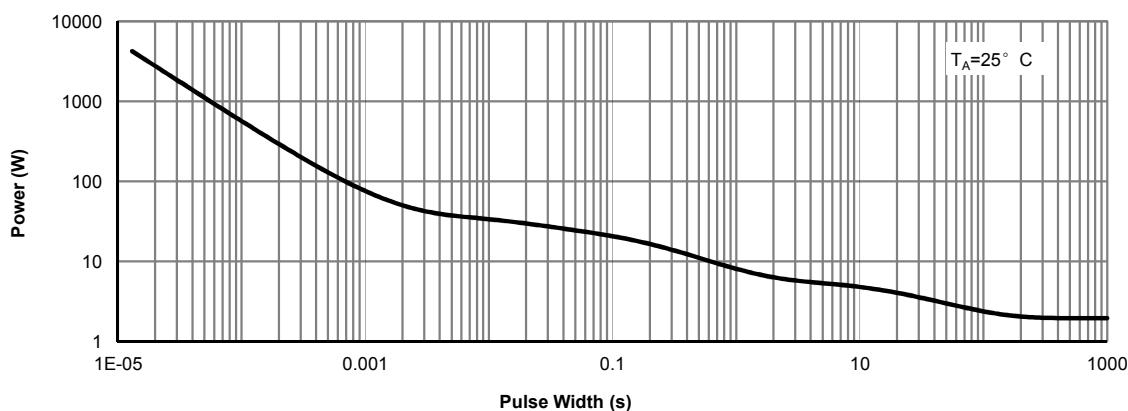
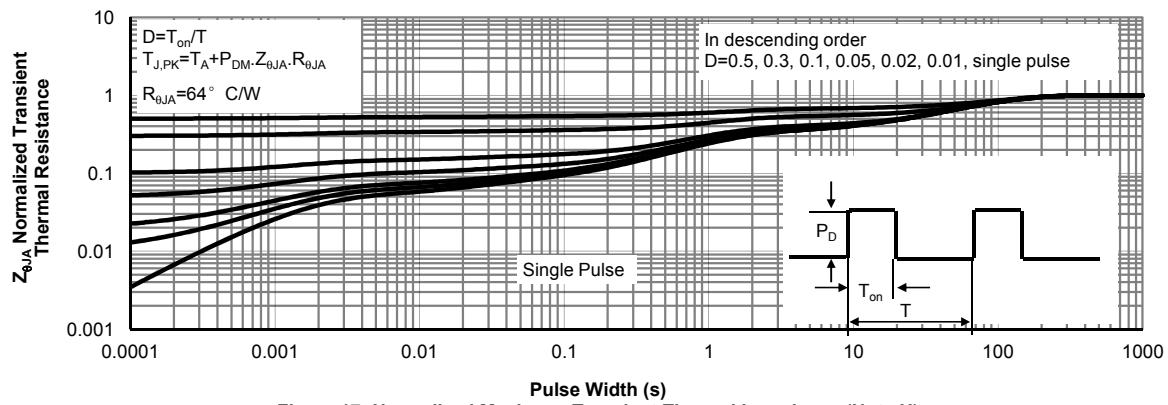


Figure 16: Single Pulse Power Rating Junction-to-Ambient (Note H)

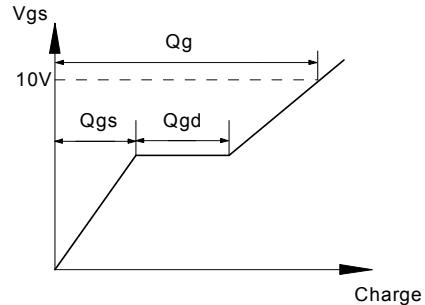
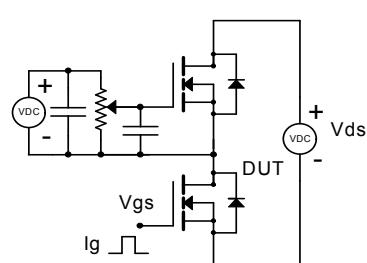


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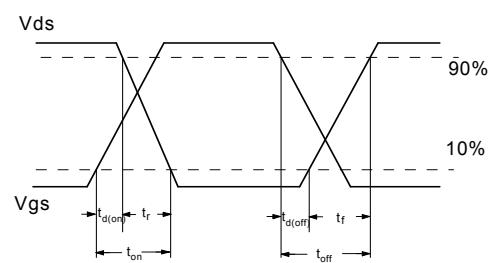
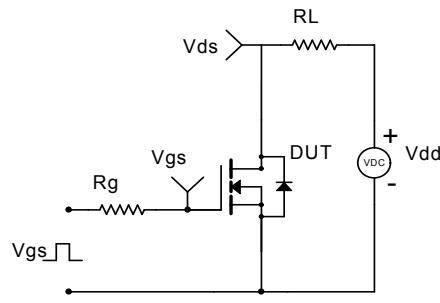




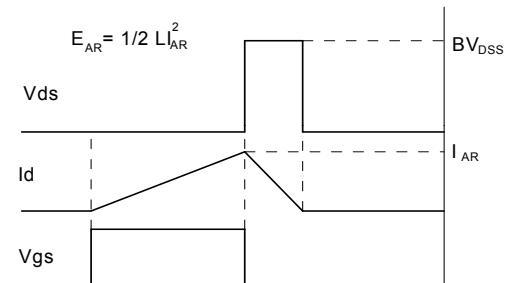
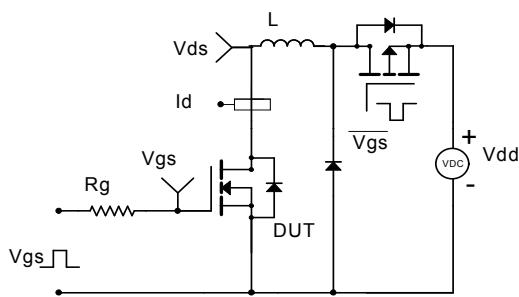
Gate Charge Test Circuit & Waveform



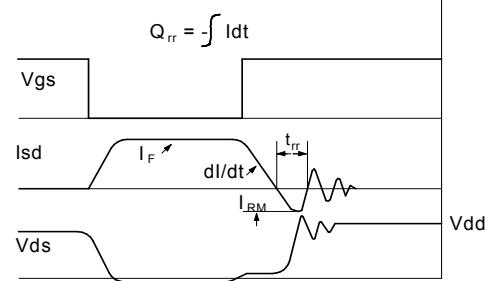
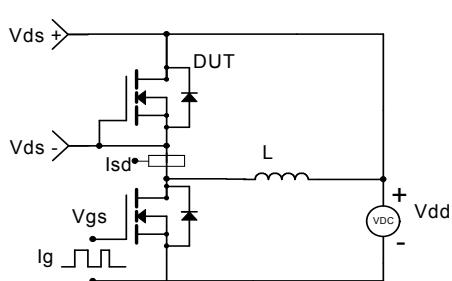
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



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